

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10576806	EONNET, YVES
<b>Examiner</b>		<b>Art Unit</b>
MARCOS BATISTA		4134

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
455	411	3/4/2008	mb
726	27	2/4/2008	mb

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Consulted with Steve D'Agosta	3/4/2008	mb
Consulted with TA - Yogesh Aggarwal	3/4/2008	mb
Consulted with Lun-Yi Lao	3/4/2008	mb
East Search	3/4/2008	mb
Inventor's Name Seach	3/4/2008	mb
Rafael Perez Gutierrez	3/4/2008	mb

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>